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## CLAIMS

## What is claimed is:

- A scan line circuit that solves screen flicker, imperfect exposure junctions and inhomogeneous brightness in the TFT-LCD, which includes a plurality of TFTs disposed in an array, each array element having a TFT, and a plurality of perpendicular scan lines and data lines, each scan line and data line connecting to a gate and source of a TFT, respectively, with the drain of the TFT connecting to a liquid crystal capacitor and a storage capacitor, wherein the scan line circuit comprising:
- a gate voltage deformation device, which connects between the gate of the first TFT and a input terminal of the scan line to deform the gate input voltage waveform connected to the scan line circuit.
  - The circuit of claim 1, wherein the gate voltage deformation device comprises a resistor.
- 3. The circuit of claim 2, wherein the resistance of the resistor is in the range between  $10\Omega/\text{sq}$  and  $100\Omega/\text{sq}$ .
  - The circuit of claim 1, wherein the gate voltage deformation device comprises an ITO thin film.
  - The circuit of claim 1, wherein the gate voltage deformation device comprises a TFT with source/gate connection.
- The circuit of claim 1, wherein the scan line is a metal wire.
  - 7. A scan line circuit that solves screen flicker, imperfect exposure junctions and inhomogeneous brightness in the TFT-LCD which has a plurality of scan lines and a plurality of data lines disposed horizontally and vertically, respectively, each of the scan lines connecting the gates of a plurality of TFTs in a row and each of the data lines connecting the

sources of a plurality of TFTs in a column, thus forming an array using the plurality of TFTs, and the drain of each of the TFTs further connecting a liquid crystal capacitor and a storage capacitor, wherein the scan line circuit comprises a resistor connected between the scan line voltage input terminal and the gate of the first connected transistor.

- 5 8. The circuit of claim 7, wherein the resistor comprises an ITO thin film.
  - 9. The circuit of claim 7, wherein the resistance of the resistor is in the range of about  $10\Omega$ /sq and  $100\Omega$ /sq.
  - 10. A scan line circuit that solves screen flicker, imperfect exposure junctions and inhomogeneous brightness in the TFT-LCD, which includes a plurality of TFTs disposed in an array, each array element having a TFT, and a plurality of perpendicular scan lines and data lines, each scan line and data line connecting to a gate and source of a TFT, respectively, with the drain of the TFT connecting to a liquid crystal capacitor and a storage capacitor, wherein the scan line circuit comprising:

gate voltage deformation means for deforming the gate input voltage waveform.

- 11. The circuit of claim 10, wherein the gate voltage deformation means comprises a resistor.
- 12. The circuit of claim 10, wherein the gate voltage deformation means comprises a TFT with source/gate connection.

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